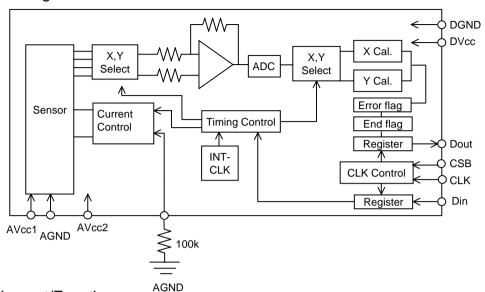


Magnetic Compass Sensor (11bits) Preliminary Data Sheet



1. Block Diagram



2. Pin Layout/Function

Pin No.	Name	I/O	Function		
1	NC				
2	NC				
3	R	_	Terminal for Internal Driving Current Setup ,Put 100k[Ohm] resistor between pin-3 & AGND.		
4	AGND	Ground	Analog Ground		
5	TMC	_	This is a Testing terminal, to be Grounded.		
6	Din	_	Serial Command		
7	Dout	0	Serial Data		
8	DGND	Ground	Digital Ground		
9	DVcc	Power	Power Supply for Digital Circuit		
10	CLK	_	Shift Clock for Data Transfer(up to 5MHz)		
11	CSB	_	Chip Select Signal		
12	MON1	_	This is a Testing terminal, to be Grounded.		
13	MON2	I	This is a Testing terminal, to be Grounded.		
14	AVcc2	Power	Power Supply for Analog Circuit		
15	AVcc1	Power	Power Supply for Analog Circuit		
16	NC				



3. Absolute Maximum Rating Over Operating

No.	Item	Symbol	Limitation	Unit
1	Power Supply	AVcc/DVcc	-0.3_+6.7	V
2	Terminal Voltage	Vin	-0.3 _Avcc/DVcc_+0.3	V
3	Operating Temp.	TOPE	-20_+85	degC
4	Storage Temp.	TSTG	-40_+100	degC
5	Max. Acceptable Loss	Р	(126)	mW

Note) In case being operated out of the range specified, the sensor/circuit may permanently be destroyed. It is desirable to be used with specified operating condition as shown 4. If it is exceeded, the product(s) may work improperly and/or may be affected to its reliable characteristics.

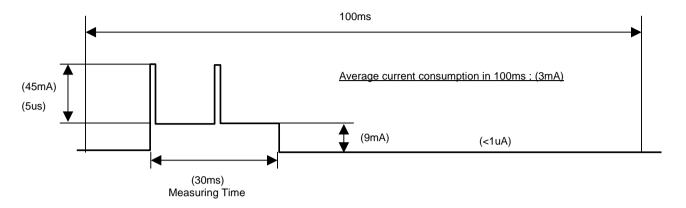
4. The electrical performance

(Vcc:2.7 -- 3.3V, Ta: -20 -- +85degC)

	Item	Symbol	Condition for measurement	Min.	Тур.	Max.	Unit
	Supply Voltage	Vcc		2.7	3.0	3.3	V
*1	Current Consumption (active)	lcc1	Measurement operation		9	13	mA
	Current Consumption (standby)(1)	lccst(1)	Ta= -20degC - +60degC, Vcc=3.0V			1	uA
	Current Consumption (standby)(2)	Iccst(2)	Ta= +60degC - +85degC, Vcc=3.0V			5	uA
*1	Current Consumption(ave)	Iccave	Measurement period:100ms		3	5	mA
	Measuring Time	Tmes			30	40	ms
	Sensitivity	Bse	Ta= 25degC, Vcc=3.0V	1.0		1.6	LSB/uT
	Magnetic field range	Н	Ta= 25degC, Vcc=3.0V, F.S.=+/-180uT	-180		180	uΤ
	Linearity	linia	Ta= 25degC, Vcc=3.0V	-5		5	% / FS
	Low-Level Input Voltage	VIL		-0.3		Vcc x 0.2	V
	High-Level Input Voltage	ViH		Vcc x 0.8		Vcc + 0.3	V
	Low-Level Output Voltage	Vol	Vcc=3V, IL=1mA	-0.3		Vcc x 0.1	V
	High-Level Output Voltage	Vон	Vcc=3V, IL= -1mA	Vcc x 0.9		Vcc + 0.3	V



Note) *1



Flg. Average current consumption in measurement

5. Interface

5 - 1. Command

1	2	3	4	Mode			
0	0	0	0	Reset			
1	0	0	0	Measurement			
1	1	0	0	Read			
0	1	0	0				

5 - 2. End flag

End flag state	Conditions affecting flags
"00"	(1)In the middle of measurement (2)RESET operation
"11"	(1) Completion of measurement
"01" "10"	Not defined 1

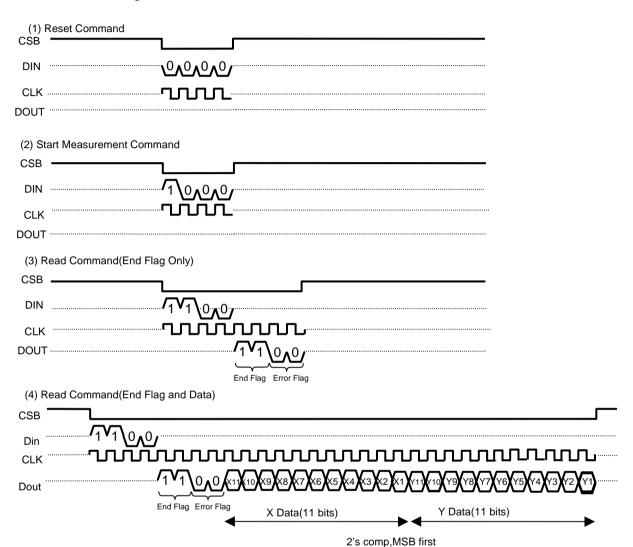
5 - 3. Error flag

Error flag state	Conditions affecting flags	
"00"	(1)Normal completion of measurement (2)RESET operation	
"11"	(1) A/D overflow in measurement	
"01" "10"	Not defined 1	





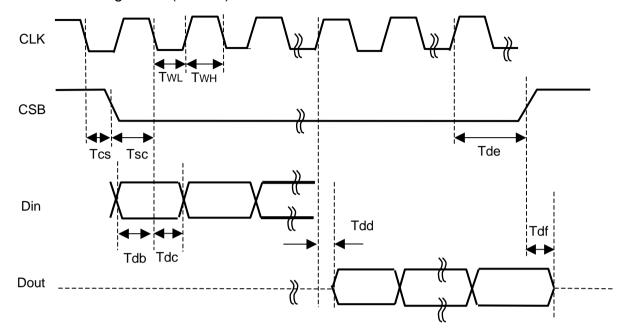
5 - 4. I/O Timing Chart







5 - 5. I/O Timing Chart (Details)



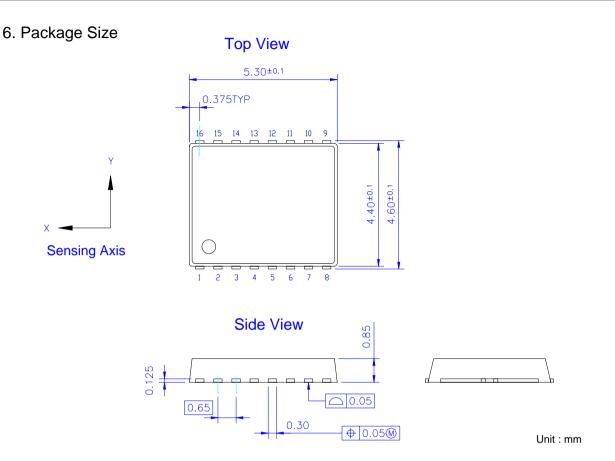
AC Timing Spec.

Item	Symbol	Min.	Тур.	Max.	Unit
CSB-CLK margin(1)	T cs	30	-	-	ns
CSB-CLK margin(2)	T sc	100	-	-	ns
CLK-Data setup time	T db	30	-	-	ns
CLK-Data hold time	T dc	30	-	-	ns
CLK-Data delay time	T dd	-	-	40	ns
CSB margin	T de	100	-	-	ns
CSB-Data delay time	T df	1	-	30	ns
CLK high time	T wh	100	-	-	ns
CLK low time	T WL	100	-	-	ns
CLK frequency	f CLK	-	1	5	MHz

Test Conditions

- (1)Ta=25 degC
- (2)Vcc=2.7V-3.3V
- (3)Load of Output=30 pF
- (4)Input ViL=0.2V ViH=Vcc-0.2V tr=10ns tf=10ns
- (5)CLK Frequency=1MHz Duty=50%





7. Recommended Foot Pattern

